Two-Wire True Zero-Speed Miniature Differential Peak-Detecting Sensor with Continuous Calibration

Package K, 4-pin SIP



- 1. VCC
- 2. No connection
- 3. Test pin (float or tie to GND)
- 4. GND

ABSOLUTE MAXIMUM RATINGS

Supply Voltage, V _{CC} 28 V
Reverse-Supply Voltage, V _{RCC} 18 V
Operating Temperature
Ambient, T _A , 40°C to 150°C
Maximum Junction, T _{J(max)} 165°C
Storage Temperature, T _c 65°C to 170°C



The A1642 is an optimized Hall effect sensing integrated circuit that provides a user-friendly solution for true zero-speed digital ring-magnet sensing in two-wire applications. This small package can be easily assembled and used in conjunction with a wide variety of target shapes and sizes.

The integrated circuit incorporates a dual-element Hall effect sensor and signal processing that switches in response to differential magnetic signals created by ring magnet poles. The circuitry contains a sophisticated digital circuit to reduce system offsets, to calibrate the gain for air-gap—independent switchpoints, and to achieve true zero-speed operation. Signal optimization occurs at power-on through the combination of offset and gain adjust and is maintained throughout the operating time with the use of a running-mode calibration. The running-mode calibration allows immunity to environmental effects such as micro-oscillations of the target or sudden air gap changes.

The regulated current output is configured for two-wire applications and the sensor is ideally suited for obtaining speed and duty cycle information in ABS (antilock braking systems). The 1.5 mm spacing between the dual Hall elements is optimized for fine pitch ring-magnet-based configurations. For applications requiring sensing of rotating ferrous gears and targets, refer to the ATS642LSH series of products. The package is lead (Pb) free, with 100% matter tin leadframe plating.

Features and Benefits

- Running mode calibration for continuous optimization
- Single chip IC for high reliability
- Internal current regulator for 2-wire operation
- Precise duty cycle signal over operating temperature range
- Large operating air gaps

- Automatic Gain Control (AGC) for air gap independent switchpoints
- Automatic Offset Adjustment (AOA) for signal processing optimization
- True zero-speed operation
- Undervoltage lockout
- · Wide operating voltage range

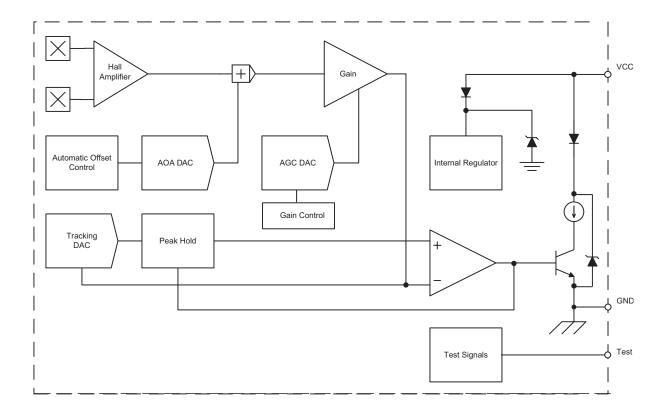
Use the following complete part numbers when ordering:

Part Number	Packing*	I _{CC} Typical		
A1642LK-I1-T	Bulk, 500 pieces/bag			
A1642LKTN-I1-T	Tape and reel, 13-inch reel 4000 pieces/reel	6.0 Low to 14.0 High mA		
A1642LK-I2-T	Bulk, 500 pieces/bag			
A1642LKTN-I2-T	Tape and reel, 13-inch reel 4000 pieces/reel	7.0 Low to 14.0 High mA		

^{*}Contact Allegro for additional packing options.



Functional Block Diagram





Two-Wire True Zero-Speed Miniature Differential Peak-Detecting Sensor with Continuous Calibration

OPERATING CHARACTERISTICS T _A and V _{CC} within specification, unless otherwise noted						
CHARACTERISTIC	Symbol	Test Conditions	Min.	Typ.1	Max.	Units
ELECTRICAL CHARACTERIS	STICS		'	•		
Supply Voltage ²	V _{CC}	perating; T _J < 165 °C 4.0		_	24	V
Undervoltage Lockout	V _{CC(UV)}	$V_{CC} \ 0 \rightarrow 5 \ V \ and \ 5 \rightarrow 0 \ V$	_	_	4.0	V
Supply Zener Clamp Voltage	V _Z	$I_{CC} = I_{CC(max)} + 3 \text{ mA}; T_A = 25^{\circ}\text{C}$	28	_	_	V
Supply Zener Current	I _Z	Test conditions only; V _Z = 28 V	_	_	I _{CC(max)} + 3 mA	mA
Supply Current	I _{CC(Low)}	A1642LK-I1	4.0	6.0	8.0	mA
		A1642LK-I2	5.9	7.0	8.4	mA
	I _{CC(High)}	A1642LK-I1	12.0	14.0	16.0	mA
		A1642LK-I2	11.8	14.0	16.8	mA
Supply Current Ratio	I _{CC(High)} /	Ratio of high current to low current	1.85	_	3.05	_
Reverse Battery Current	I _{RCC}	V _{RCC} = -18 V	_	_	- 5	mA
POWER-ON STATE CHARAC	TERISTICS					
Power-On State ³	POS	t > t _{PO}	_	I _{CC(High)}	_	_
Power-On Time ⁴	t _{PO}	f _{OP} < 100 Hz	_	1	2	ms
OUTPUT STAGE	1		1	1		
Output Slew Rate ⁵	dl/dt	R_{LOAD} = 100 Ω , C_{LOAD} = 10 pF	_	14	_	mA/µs

Continued on the next page.



Two-Wire True Zero-Speed Miniature Differential Peak-Detecting Sensor with Continuous Calibration

OPERATING CHARACTERISTICS (continued) T _A and V _{CC} within specification, unless otherwise noted							
Characteristic	Symbol	Test Conditions	Min.	Typ.1	Max.	Units	
SWITCHPOINT CHARACTERISTICS							
Operating Speed	f _{OP}		0	_	8,000	Hz	
Analog Signal Bandwidth	BW	Equivalent to f – 3 dB	20	40	_	kHz	
Operate Point	B _{OP}	Transitioning from $I_{CC(High)}$ to $I_{CC(Low)}$; positive peak referenced; AG < AG _{MAX}	-	120	_	mV	
Release Point	B _{RP}	Transitioning from $I_{CC(Low)}$ to $I_{CC(High)}$; negative peak referenced; AG < AG _{MAX}	-	120	_	mV	
CALIBRATION							
Initial Calibration	Cı	Quantity of rising output (current) edges required for accurate edge detection	-	_	3	Edge	
DAC CHARACTERISTICS							
Allowable User-Induced Differential Offset		Operating within specification	_	_	±90	G	
FUNCTIONAL CHARACTERISTICS ⁶							
Operating Signal Range ⁷	Sig	Operating within specification	30	_	1000	G	
Minimum Operating Signal	Sig _{OP(min)}	Output switching (no missed edges); ΔDC not guaranteed	20	_	_	G	

¹Typical values are at T_A = 25°C and V_{CC} = 12 V. Performance may vary for individual units, within the specified maximum and minimum limits.



²Maximum voltage must be adjusted for power dissipation and junction temperature; see *Power Derating* section.

³Please refer to Sensor Operation section, page 11.

⁴Power-On Time includes the time required to complete the internal automatic offset adjust. The DACs are then ready for peak acquisition.

 $^{^{5}}$ dI is the difference between 10% of $I_{CC(Low)}$ and 90% of $I_{CC(High)}$, and dt is time period between those two points.

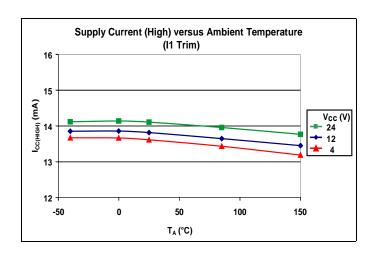
Note: di/dt is dependent upon the value of the bypass capacitor, if one is used.

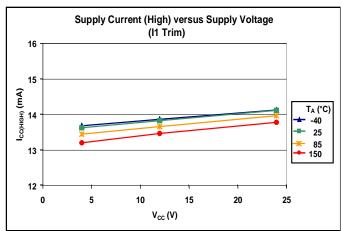
⁶Functional characteristics valid only if magnetic offset is within the specified range for Allowable User Induced Differential Offset.

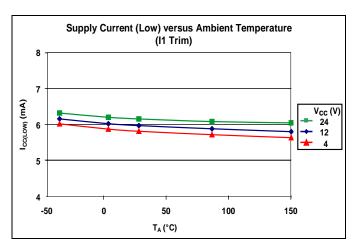
⁷In order to remain in specification, the magnetic gradient must induce an operating signal greater than the minimum value specified. This includes the effect of target wobble.

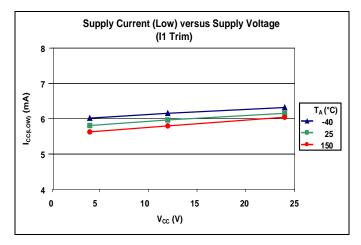
Two-Wire True Zero-Speed Miniature Differential Peak-Detecting Sensor with Continuous Calibration

Characteristic Data



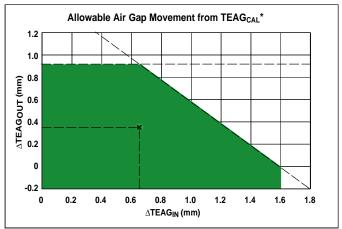






Two-Wire True Zero-Speed Miniature Differential Peak-Detecting Sensor with Continuous Calibration

Characteristic Allowable Air Gap Movement

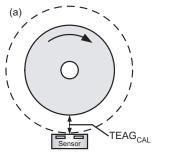


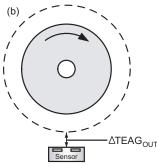
*Data based on study performed using spur gear reference target 60-0, and applicable to ring magnet targets with similar magnetic characteristics.

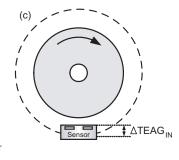
The colored area in the chart above shows the region of allowable air gap movement within which the sensor will continue output switching. The output duty cycle is wholly dependent on the target's magnetic signature across the air gap range of movement, and may not always be within specification throughout the entire operating region (to AG_(OPmax)).

The axis parameters for the chart are defined in the drawings below. As an example, assume the case where the air gap is allowed to vary from from the nominal installed air gap (TEAG_{CAL}, panel a) within the range defined by an increase of $\Delta TEAG_{OUT} = 0.35$ mm (shown in panel b), and a decrease of $\Delta TEAG_{IN} = 0.65$ mm (shown in panel c). This case is plotted with an "x" in the chart above.

For more information on these figures and the calculations used to generate them, please refer to the Applications Note Determining Allowable Air Gap Variation for the ATS642.







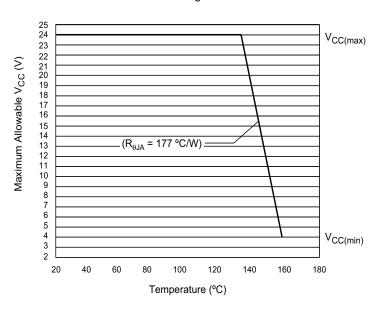
Two-Wire True Zero-Speed Miniature Differential Peak-Detecting Sensor with Continuous Calibration

THERMAL CHARACTERISTICS may require derating at maximum conditions, see application information

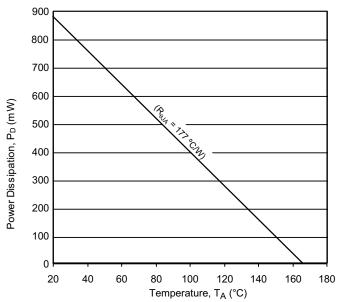
CHARACTERISTIC	Symbol	TEST CONDITIONS*	Value	Units
Package Thermal Resistance	$R_{\theta JA}$	Single-layer PCB with copper limited to solder pads	177	°C/W

^{*}Additional information is available on the Allegro Web site.

Power Derating Curve



Power Dissipation versus Ambient Temperature



Two-Wire True Zero-Speed Miniature Differential Peak-Detecting Sensor with Continuous Calibration

Functional Description

Sensing Technology

The single-chip differential Hall effect sensor IC possesses two Hall elements, which sense the magnetic profile of the ring magnet simultaneously, but at different points (spaced at a 1.5 mm pitch), generating a differential internal analog voltage, V_{PROC}, that is processed for precise switching of the digital output signal.

The Hall IC is self-calibrating and also possesses a temperature compensated amplifier and offset compensation circuitry. Its voltage regulator provides supply noise rejection throughout the operating voltage range. Changes in temperature do not greatly affect this device due to the stable amplifier design and the offset compensation circuitry. The Hall transducers and signal processing electronics are integrated on the same silicon substrate, using a proprietary BiCMOS process.

Target Profiling

An operating device is capable of providing digital information that is representative of the magnetic features on a rotating target. The waveform diagram shown in figure 3 presents the automatic translation of the magnetic profile to the digital output signal of the sensor.

Output Polarity

Figure 3 shows the output polarity for the orientation of target and sensor shown in figure 2. The target direction of rotation

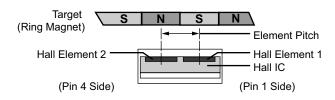


Figure 1. Relative motion of the target is detected by the dual Hall elements mounted on the Hall IC.

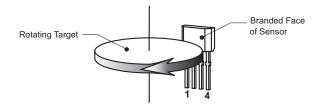


Figure 2. This left-to-right (pin 1 to pin 4) direction of target rotation results in a low output signal when a magnetic north pole of the target is nearest the face of the sensor (see figure 3). A right-to-left (pin 4 to pin 1) rotation inverts the output signal polarity.

shown is: perpendicular to the leads, across the face of the device, from the pin 1 side to the pin 4 side. This results in the sensor output switching from high, I_{CC(High)}, to low I_{CC(Low)}, as the leading edge of a north magnetic pole passes the sensor face. In this configuration, the device output current switches to its low polarity when a north pole is the target feature nearest to the sensor. If the direction of rotation is reversed, then the output polarity inverts.

Note that output voltage polarity is dependent on the position of the sense resistor, R_{SENSE} (see figure 4).

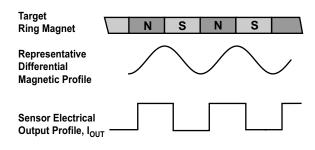


Figure 3. Output Profile of a ring magnet target for the polarity indicated in figure 2.

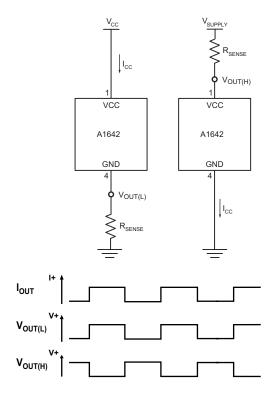


Figure 4: Voltages profiles for high side and low side two-wire sensing.

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Two-Wire True Zero-Speed Miniature Differential Peak-Detecting Sensor with Continuous Calibration

Automatic Gain Control (AGC)

This feature allows the device to operate with an optimal internal electrical signal, regardless of the air gap (within the AG specification). During calibration, the device determines the peak-topeak amplitude of the signal generated by the target. The gain of the sensor is then automatically adjusted. Figure 5 illustrates the effect of this feature.

Automatic Offset Adjust (AOA)

The AOA is patented circuitry that automatically compensates for the effects of chip, magnet, and installation offsets. (For capability, see Dynamic Offset Cancellation, in the Operating Characteristics table.) This circuitry is continuously active, including both during calibration mode and running mode, compensating for any offset drift. Continuous operation also allows it to compensate for offsets induced by temperature variations over time.

Digital Peak Detection

A digital DAC tracks the internal analog voltage signal V_{PROC}, and is used for holding the peak value of the internal analog signal. In the example shown in figure 6, the DAC would first track up with the signal and hold the upper peak's value. When V_{PROC} drops below this peak value by B_{OP}, the device hysteresis, the output would switch and the DAC would begin tracking the signal downward toward the negative V_{PROC} peak. Once the DAC acquires the negative peak, the output will again switch states when V_{PROC} is greater than the peak by the value B_{RP} . At this point, the DAC tracks up again and the cycle repeats. The digital tracking of the differential analog signal allows the sensor to achieve true zero-speed operation.

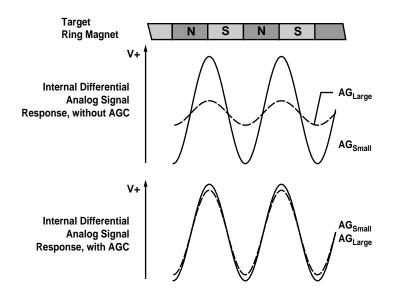


Figure 5. Automatic Gain Control (AGC). The AGC function corrects for variances in the air gap. Differences in the air gap affect the magnetic gradient, but AGC prevents that from affecting device performance, as shown in the lowest panel.

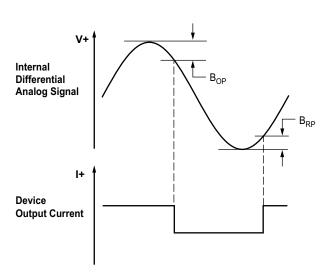


Figure 6: Peak Detecting Switchpoint Detail

Two-Wire True Zero-Speed Miniature Differential Peak-Detecting Sensor with Continuous Calibration

Power Supply Protection

The device contains an on-chip regulator and can operate over a wide V_{CC} range. For devices that need to operate from an unregulated power supply, transient protection must be added externally. For applications using a regulated line, EMI/RFI protection may still be required. Contact Allegro Microsystems for information on the circuitry needed for compliance with various EMC specifications. Refer to figure 7 for an example of a basic application circuit.

Undervoltage Lockout

When the supply voltage falls below the undervoltage lockout voltage, V_{CC(UV)}, the device enters Reset, where the output state returns to the Power-On State (POS) until sufficient V_{CC} is supplied. I_{CC} levels may not meet datasheet limits when $V_{CC} < V_{CC(min)}$

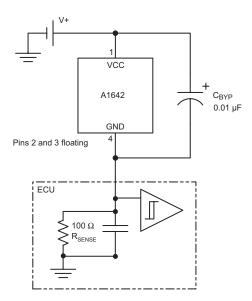


Figure 7: Typical Application Circuit

Assembly Description

This sensor is integrally molded into a plastic body that has been optimized for size, ease of assembly, and manufacturability. High operating temperature materials are used in all aspects of construction.

Diagnostics

The regulated current output is configured for two wire applications, requiring one less wire for operation than do switches with the more traditional open-collector output. Additionally, the system designer inherently gains diagnostics because there is always output current flowing, which should be in either of two narrow ranges, shown in figure 8 as I_{CC(High)} and I_{CC(Low)}. Any current level not within these ranges indicates a fault condition. If $I_{CC}\!>\!I_{CC(High)max}\!,$ then a short condition exists, and if $I_{CC} \le I_{CC(low)min}$, then an open condition exists. Any value of I_{CC} between the allowed ranges for I_{CC(High)} and I_{CC(Low)} indicates a general fault condition.

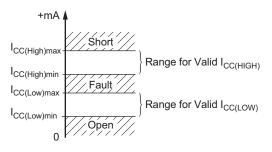


Figure 8: Diagnostic Characteristics of Supply Current Values

Two-Wire True Zero-Speed Miniature Differential Peak-Detecting Sensor with Continuous Calibration

SENSOR OPERATION

Each operating mode is described in detail below.

Power-On

When power $(V_{CC} > V_{CC(Min)})$ is applied to the device, a short period of time is required to power the various portions of the IC. During this period, the A1642 powers-on in the high current state, $I_{CC(High)}$. After power-on, there are conditions that could induce a change in the output state. Such an event could be caused by thermal transients, but would require a static applied magnetic field, proper signal polarity, and particular direction and magnitude of internal signal drift.

Initial Offset Adjust

The sensor initially cancels the effects of chip, magnet, and installation offsets. Once offsets have been cancelled, the digital tracking DAC is ready to track the signal and provide output switching. The period of time required for both Power-On and Initial Offset Adjust is defined as the Power-On Time.

Calibration Mode

The calibration mode allows the sensor to automatically select the proper signal gain and continue to adjust for offsets. The

AGC is active, and selects the optimal signal gain based on the amplitude of the V_{PROC} signal. Following each adjustment to the AGC DAC, the Offset DAC is also adjusted to ensure the internal analog signal is properly centered.

During this mode, the tracking DAC is active and output switching occurs, but the duty cycle is not guaranteed to be within specification.

Running Mode

After the Initial Calibration period, C_I, establishes a signal gain, the device moves to Running mode. During Running mode, the sensor tracks the input signal and gives an output edge for every peak of the signal. AOA remains active to compensate for any offset drift over time.

The A1642 incorporates a novel algorithm for adjusting the signal gain during Running mode. This algorithm is designed to optimize the V_{PROC} signal amplitude in instances where the magnetic signal "seen" during the calibration period is not representative of the amplitude of the magnetic signal for the installed sensor air gap (see figure 9).

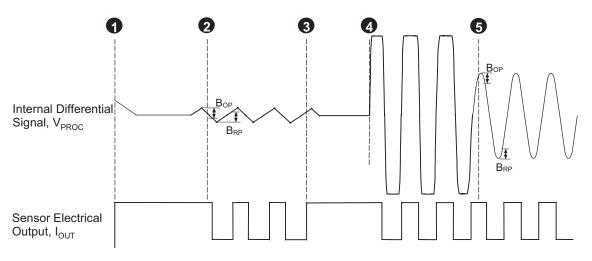


Figure 9: Operation of Running Mode Gain Adjust.

Position 1. The device is initially powered-on. Self-calibration occurs.

Position 2. Small amplitude oscillation of the target sends an erroneously small differential signal to the sensor. The amplitude of V_{PROC} is greater than the switching hysteresis (B_{OP} and B_{RP}), and the device output switches.

Position 3. The calibration period completes on the third rising output edge, and the device enters Running mode.

Position 4. True target rotation occurs and the correct magnetic signal is generated for the installation air gap. The established signal gain is too large for the target's rotational magnetic signal at the given air gap.

Position 5. Running Mode Calibration corrects the signal gain to an optimal level for the installation air gap.



Two-Wire True Zero-Speed Miniature Differential Peak-Detecting Sensor with Continuous Calibration

Power Derating

The device must be operated below the maximum junction temperature of the device, T_{J(max)}. Under certain combinations of peak conditions, reliable operation may require derating supplied power or improving the heat dissipation properties of the application. This section presents a procedure for correlating factors affecting operating T_I. (Thermal data is also available on the Allegro MicroSystems Web site.)

The Package Thermal Resistance, $R_{\theta JA}$, is a figure of merit summarizing the ability of the application and the device to dissipate heat from the junction (die), through all paths to the ambient air. Its primary component is the Effective Thermal Conductivity, K, of the printed circuit board, including adjacent devices and traces. Radiation from the die through the device case, $R_{\theta JC}$, is relatively small component of $R_{\theta JA}$. Ambient air temperature, T_A, and air motion are significant external factors, damped by overmolding.

The effect of varying power levels (Power Dissipation, P_D), can be estimated. The following formulas represent the fundamental relationships used to estimate T_I, at P_D.

$$P_D = V_{IN} \times I_{IN} \tag{1}$$

$$\Delta T = P_D \times R_{\theta IA} \tag{2}$$

$$T_{I} = T_{A} + \Delta T \tag{3}$$

For example, given common conditions such as: $T_A = 25$ °C, $V_{CC} = 12 \text{ V}$, $I_{CC} = 4 \text{ mA}$, and $R_{\theta JA} = 177 \text{ °C/W}$, then:

$$P_D = V_{CC} \times I_{CC} = 12 \text{ V} \times 4 \text{ mA} = 48 \text{ mW}$$

$$\Delta T = P_D \times R_{HIA} = 48 \text{ mW} \times 177 \text{ °C/W} = 8.5 \text{ °C}$$

$$T_J = T_A + \Delta T = 25^{\circ}C + 8.5^{\circ}C = 33.5^{\circ}C$$

A worst-case estimate, P_{D(max)}, represents the maximum allowable power level ($V_{CC(max)}$, $I_{CC(max)}$), without exceeding $T_{J(max)}$, at a selected $R_{\theta JA}$ and T_A .

Example: Reliability for V_{CC} at T_A=150°C, package K (I1 trim), using minimum-K PCB

Observe the worst-case ratings for the device, specifically: $R_{\theta JA} = 177^{\circ}C/W$, $T_{J(max)} = 165^{\circ}C$, $V_{CC(max)} = 24V$, and $I_{CC(max)} = 16 \text{ mA}.$

Calculate the maximum allowable power level, $P_{D(max)}$. First, invert equation 3:

$$\Delta T_{\text{max}} = T_{\text{J(max)}} - T_{\text{A}} = 165 \,^{\circ}\text{C} - 150 \,^{\circ}\text{C} = 15 \,^{\circ}\text{C}$$

This provides the allowable increase to T_I resulting from internal power dissipation. Then, invert equation 2:

$$P_{D(max)} = \Delta T_{max} \div R_{\theta JA} = 15^{\circ}C \div 177^{\circ}C/W = 84.7 \text{ mW}$$

Finally, invert equation 1 with respect to voltage:

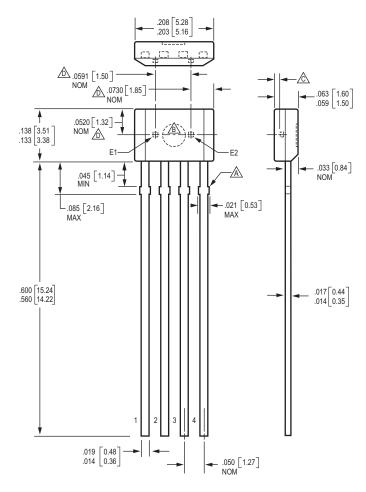
$$V_{CC(est)} = P_{D(max)} \div I_{CC(max)} = 84.7 \text{ mW} \div 16 \text{ mA} = 5.3 \text{ V}$$

The result indicates that, at T_A , the application and device can dissipate adequate amounts of heat at voltages $\leq V_{CC(est)}$.

Compare $V_{CC(est)}$ to $V_{CC(max)}$. If $V_{CC(est)} \le V_{CC(max)}$, then reliable operation between $V_{CC(est)}$ and $V_{CC(max)}$ requires enhanced $R_{\theta JA}$. If $V_{CC(est)} \ge V_{CC(max)}$, then operation between $V_{CC(est)}$ and $V_{CC(max)}$ is reliable under these conditions.



Package K



Dimensions in inches

Millimeters in brackets, for reference only

Case dimensions exclusive of mold flash or gate burrs

Mold flash .010 [0.25] MAX, gate burr .008 [0.20] MAX, dambar protrusion .004 [0.10] MAX

Exact case and lead configuration at supplier discretion within limits shown

A Dambar removal protrusion (8X)

Ejector mark on opposite side

Active Area Depth .0165 [0.42] NOM

Hall elements E1, E2 placement (element size not to scale)

The products described herein are manufactured under one or more of the following U.S. patents: 5,045,920; 5,264,783; 5,442,283; 5,389,889; 5,581,179; 5,517,112; 5,619,137; 5,621,319; 5,650,719; 5,686,894; 5,694,038; 5,729,130; 5,917,320; and other patents pending.

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